
Dear colleagues!

The very hard year of 2016 is over. The Dependability Journal has lost three of its colleagues. G.N. Cherkosov, A.A. Tarasov and E.V. Dzirkal have passed away. They were great scientists and remarkable people. They contributed a lot to the Journals' development.

The losses though did not prevent the members of the Editorial Board and Editorial Team from taking active measures to enhance the Journal's scientific and technical level, promote its publications and get them included in the RSCI index, as well as international databases and citation systems, such as Scopus and Web of Science (WoS), that is expected in the nearest future. According to the Scopus requirements, a bilingual website of the Dependability Journal (www.dependability.ru) has been developed and is now fully operational.

In 2017, Dependability will be published in Russian and English. It is planned to use the website to allow readers conditional access to the electronic versions of the current and previous issues.

The subject matter of the Journal remains largely unchanged: structural and functional reliability of technical and man-machine systems, functional safety of control and safety systems, fail-safety and survivability of systems, standardization and certification in the area of system dependability and safety. The subject matter of the publications is to be extended to functional safety, management of fire, occupational, environmental risks, as well as information security.

The priority is given to items that reflect the results of practical application of advanced technologies, methods and engineering solutions.

The Journal is open for publication of advertisement materials highlighting the latest achievements in the area of design, application and development of technical systems and processes as regards their dependability and safety.

The editorial board calls the authors and readers for active involvement with the Journal. Your observations and proposals will help improve its quality, as well as its scientific and application level.

Best of luck in the year of 2017.

Best regards, I.B. Shubinsky, Professor, Editor-in-Chief